

YJ Planar Schottky Barrier Diode Die Specification

20V 1A, 28mil, Schottky barrier diode die based on silicon planar process

Part No.: PSB028L020SS-280A

Main Products Characteristics

- Average forward current: $I_{F(AV)} = 1 \text{ A}$
- Maximum operating junction temperature: $T_j = 125 \text{ }^\circ\text{C}$
- ESD rating: >8KV, per IEC61000-4-2 (Contact Discharge)
- Top metal: Ag

Maximum Ratings

Parameter	Symbol	Rating
Repetitive peak reverse voltage	V_{RRM}	20 V
Average forward current	$I_{F(AV)}$	1 A
Non-repetitive peak surge current ($t_p = 8.3 \text{ ms}$, halfwave, 1 cycle)	I_{FSM}	30 A
Storage temperature range	T_{stg}	-50 to +125 °C
Maximum operating junction temperature	T_j	125 °C

Static Electrical Characteristics ($T_a = 25^\circ\text{C}$)

Parameter	Symbol	Value	
		Spec	Typical
Reverse breakdown voltage $I_R = 1\text{mA}$	V_{BR}	25 V	32V
Maximum forward voltage drop $I_F = 1 \text{ A}$ Pulse Test: $t_p = 300 \mu\text{s}$, 2%	V_F	0.45V	0.43V
Maximum reverse current $V_R = V_{RRM}$ Pulse Test: $t_p = 300 \mu\text{s}$, 2%	I_R	50uA	10uA

Device Schematics and Outline Drawing

Die Thickness *	11 Mils
Die Size **	30 Mils
Top Metal Pad	26.8 Mils
Active Area	23.3 Mils
Top Metal	Ag
Back Metal	Ag
Note: 1 * : Also can offer device with 8 mils thickness	
2 **: Cutting street width is around 1.5 mils	

Important Notice

Specification apply to die only. Actual performance may degrade when assembled.

does not guarantee device performance after assembly.

All operating parameters must be validated for each customer application by customer's technical experts.

Data sheet information is subjected to change without notice.

Recommended Storage Environment:

Store in original container, in dessicated nitrogen, with no contamination.

Shelf life for parts stored in above condition is 2 years.

If the storage is done in normal atmosphere shelf life is reduced to 6 months.

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